MSKSEMI 美森科













ESD

TV/S

TSS

MOV

GDT

PIFD

AO3434A

Product specification





Features

- 30V,4.0A , RDS(ON)=42mΩ@VGS=10V
- Improved dv/dt capability
- Fast switching
- Green Device Available

Applications

- MB / VGA / Vcore
- Load Switch
- Hand-Held Instrument

BVDSS	RDSON	ID
30V	42mΩ	4.0A

Reference News

PACKAGE OUTLINE	PIN Configuration	Marking
SOT-23-3L	D o o o o o o o o o o o o o o o o o o o	Y4* *× ≍

Absolute Maximum Ratings Tc=25℃ unless otherwise noted

Symbol	Parameter	Rating	Units
Vos	Drain-Source Voltage	30	V
Vgs	Gate-Source Voltage	±12	V
l _D	Drain Current - Continuous (T _A =25°C)		А
	Drain Current - Continuous (T _A =70°C)	2.5	А
IDM	Drain Current - Pulsed ¹	16	Α
 Pp	Power Dissipation (T _A =25°C)	278	mW
PD	Power Dissipation - Derate above 25°C	2.22	mW/°C
Тѕтс	Storage Temperature Range	-50 to 150	°C
TJ	Operating Junction Temperature Range	-50 to 150	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction to ambient		450	°C/W



Electrical Characteristics (TJ=25 ℃, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	Vgs=0V , Ip=250uA	30			V
△BVbss/△TJ	BVDSS Temperature Coefficient	Reference to 25°C , I⊳=1mA		0.018		V/°C
lana	Drain-Source Leakage Current	V _{DS} =30V , V _{GS} =0V , T _J =25°C			1	uA
IDSS	Diam-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =125℃			10	uA
Igss	Gate-Source Leakage Current	Vgs= ±12V , Vps=0V			±100	nA

On Characteristics

RDS(ON)	Static Drain-Source On-Resistance	Vgs=10V , ID=3A		45	60	mΩ
		Vgs=4.5V , Ip=2A		50	70	mΩ
V _{GS(th)}	Gate Threshold Voltage	-Vgs=Vds , Id =250uA	0.5	1.0	2.5	V
$\triangle V$ GS(th)	V _{GS(th)} Temperature Coefficient	VG3-VD3 , ID -230UA		-3.2		mV/℃
gfs	Forward Transconductance	V _{DS} =10V , I _D =2A		2.3		S

Dynamic and switching Characteristics

Qg	Total Gate Charge ^{2,3}			3.1	
Qgs	Gate-Source Charge ^{2, 3}	V _{DS} =24V , V _{GS} =10V , I _D =1A	I	0.1	 nC
Qgd	Gate-Drain Charge ^{2, 3}			1.7	
T _d (on)	Turn-On Delay Time ^{2,3}			2.2	
Tr	Rise Time ^{2, 3}	V _{DD} =24V , V _{GS} =10V ,		6.9	
T _d (off)	Turn-Off Delay Time ^{2, 3}	Rg=3.3Ω lb=1A		15.2	 ns
Tf	Fall Time ^{2, 3}			4.5	
Ciss	Input Capacitance			245	
Coss	Output Capacitance	V _{DS} =25V , V _{GS} =0V , F=1MHz		40	 pF
Crss	Reverse Transfer Capacitance			78	

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current	V _G =V _D =0V , Force Current			4.0	Α
lsм	Pulsed Source Current	Vo VB OV , I oloo Gallone			8.0	Α
Vsp	Diode Forward Voltage	Vgs=0V,Is=1A,TJ=25℃			1.2	V

Note:

- Repetitive Rating : Pulsed width limited by maximum junction temperature. The data tested by pulsed , pulse width ≤ 300 us , duty cycle $\leq 2\%$. 1.
- 2.
- Essentially independent of operating temperature. 3.

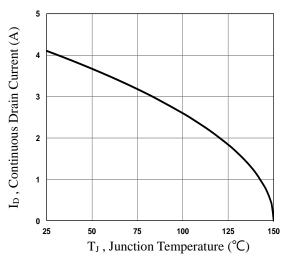


Fig.1 Continuous Drain Current vs. TJ

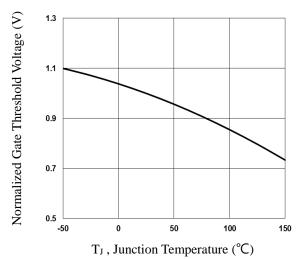


Fig.3 Normalized V_{th} vs. T_J

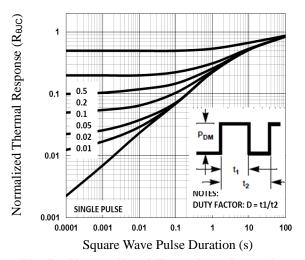


Fig.5 Normalized Transient Impedance

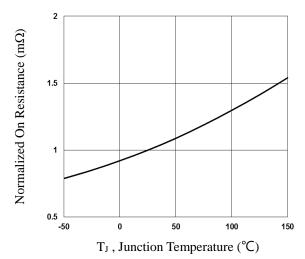


Fig.2 Normalized RDSON vs. TJ

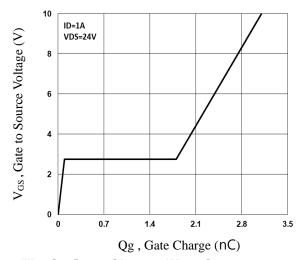


Fig.4 Gate Charge Waveform

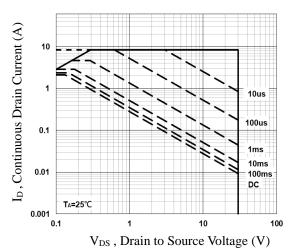
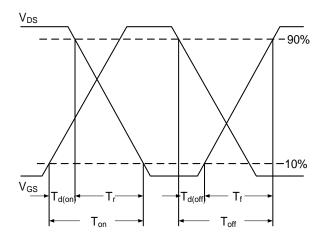


Fig.6 Maximum Safe Operation Area



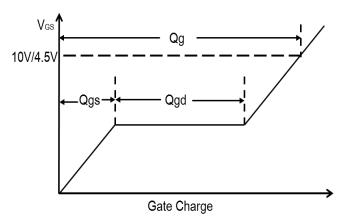
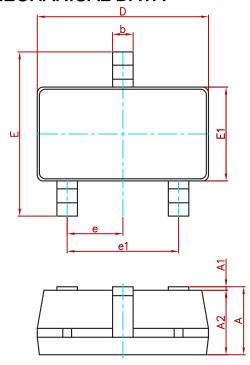


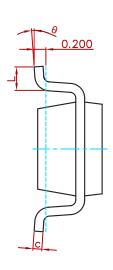
Fig.7 Switching Time Waveform

Fig.8 Gate Charge Waveform



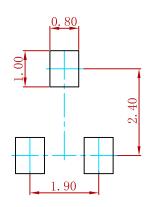
PACKAGE MECHANICAL DATA





Symbol	Dimensions II	Dimensions In Millimeters		s In Inches
Symbol	Min.	Max.	Min.	Max.
Α	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.500	0.012	0.020
С	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E1	1.500	1.700	0.059	0.067
E	2.650	2.950	0.104	0.116
е	0.950(BSC)	0.037((BSC)
e1	1.800	2.000	0.071	0.079
L	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°

Suugested Pad Layout



Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.

REELSPECIFICATION

P/N	PKG	QTY
AO3434A	SOT-23-3L	3000



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